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FDMA1032CZ

20V Complementary PowerTrench® MOSFET

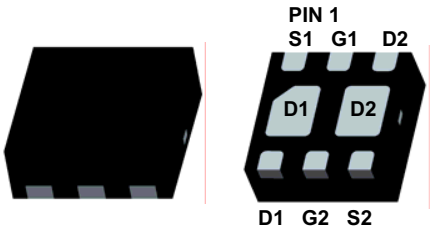
July 2014

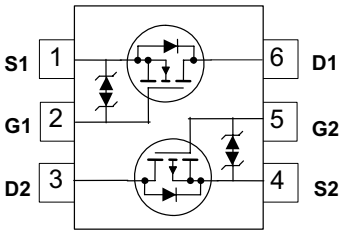
General Description

This device is designed specifically as a single package solution for a DC/DC 'Switching' MOSFET in cellular handset and other ultra-portable applications. It features an independent N-Channel & P-Channel MOSFET with low on-state resistance for minimum conduction losses. The gate charge of each MOSFET is also minimized to allow high frequency switching directly from the controlling device. The MicroFET 2x2 package offers exceptional thermal performance for its physical size and is well suited to switching applications.

Features

- Q1: N-Channel
  3.7 A, 20V. $R_{DS(ON)}$ = 68 mΩ @ V_{GS} = 4.5V
  $R_{DS(ON)}$ = 86 mΩ @ V_{GS} = 2.5V
- Q2: P-Channel
  –3.1 A, –20V. $R_{DS(ON)}$ = 95 mΩ @ V_{GS} = –4.5V
  $R_{DS(ON)}$ = 141 mΩ @ V_{GS} = –2.5V
- Low profile – 0.8 mm maximum – in the new package MicroFET 2x2 mm
- HBM ESD protection level > 2 kV (Note 3)
- RoHS Compliant
- Free from halogenated compounds and antimony oxides





MicroFET 2x2

Absolute Maximum Ratings

T_A=25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V_{DS}	Drain-Source Voltage		20	–20	V
V_{GS}	Gate-Source Voltage		±12	±12	V
I_D	Drain Current – Continuous	(Note 1a)	3.7	–3.1	A
	– Pulsed		6	–6	
P_D	Power Dissipation for Single Operation	(Note 1a)	1.4		W
		(Note 1b)	0.7		
T_J, T_{STG}	Operating and Storage Junction Temperature Range		–55 to +150		°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	86 (Single Operation)	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	173 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	69 (Dual Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	151 (Dual Operation)	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
032	FDMA1032CZ	7”	8mm	3000 units

Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Off Characteristics							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA V_{GS} = 0 V, I_D = –250 μA	Q1 Q2	20 –20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = –250 μA, Referenced to 25°C	Q1 Q2		15 –12		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 16 V, V_{GS} = 0 V V_{DS} = –16 V, V_{GS} = 0 V	Q1 Q2			1 –1	μA
I_{GSS}	Gate-Body Leakage	V_{GS} = ±12 V, V_{DS} = 0 V	All			±10	μA
On Characteristics (Note 2)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA V_{DS} = V_{GS}, I_D = –250 μA	Q1 Q2	0.6 –0.6	1.0 –1.0	1.5 –1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = –250 μA, Referenced to 25°C	Q1 Q2		–4 4		mV/°C
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 4.5 V, I_D = 3.7 A V_{GS} = 2.5 V, I_D = 3.3 A V_{GS} = 4.5 V, I_D = 3.7 A, T_J = 125°C	Q1		37 50 53	68 86 90	mΩ
		V_{GS} = –4.5V, I_D = –3.1 A V_{GS} = –2.5 V, I_D = –2.5 A V_{GS} = –4.5 V, I_D = –3.1 A, T_J = 125°C	Q2		60 88 87	95 141 140	mΩ
g_{FS}	Forward Transconductance	V_{DS} = 10 V, I_D = 3.7 A V_{DS} = –10 V, I_D = –3.1 A	Q1 Q2		16 –11		S
Dynamic Characteristics							
C_{iss}	Input Capacitance	Q1 V_{DS} = 10 V, V_{GS} = 0 V, f = 1.0 MHz	Q1 Q2		340 540		pF
C_{oss}	Output Capacitance	Q2 V_{DS} = –10 V, V_{GS} = 0 V, f = 1.0 MHz	Q1 Q2		80 120		pF
C_{rss}	Reverse Transfer Capacitance		Q1 Q2		60 100		pF
Switching Characteristics (Note 2)							
$t_{d(on)}$	Turn-On Delay Time	Q1 V_{DD} = 10 V, I_D = 1 A, V_{GS} = 4.5 V, R_{GEN} = 6 Ω	Q1 Q2		8 13	16 24	ns
t_r	Turn-On Rise Time		Q1 Q2		8 11	16 20	ns
$t_{d(off)}$	Turn-Off Delay Time	Q2 V_{DD} = –10 V, I_D = –1 A, V_{GS} = –4.5 V, R_{GEN} = 6 Ω	Q1 Q2		14 37	26 59	ns
t_f	Turn-Off Fall Time		Q1 Q2		3 36	6 58	ns
Q_g	Total Gate Charge	Q1 V_{DS} = 10 V, I_D = 3.7 A, V_{GS} = 4.5 V	Q1 Q2		4 7	6 10	nC
Q_{gs}	Gate-Source Charge	Q2 V_{DS} = –10 V, I_D = –3.1 A, V_{GS} = –4.5 V	Q1 Q2		0.7 1.1		nC
Q_{gd}	Gate-Drain Charge		Q1 Q2		1.1 2.4		nC

Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Drain–Source Diode Characteristics and Maximum Ratings							
I_S	Maximum Continuous Source-Drain Diode Forward Current		Q1 Q2			1.1 –1.1	A
V_{SD}	Source-Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 1.1 A (Note 2) V_{GS} = 0 V, I_S = –1.1 A (Note 2)	Q1 Q2		0.7 –0.8	1.2 –1.2	V
t_{rr}	Diode Reverse Recovery Time	Q1 I_F = 3.7 A, dI_F/dt = 100 A/µs	Q1 Q2		11 25		ns
Q_{rr}	Diode Reverse Recovery Charge	Q2 I_F = –3.1 A, dI_F/dt = 100 A/µs	Q1 Q2		2 9		nC

Notes:

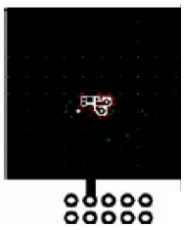
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.

   (a) $R_{\theta JA}$ = 86 °C/W when mounted on a 1 in^2 pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.

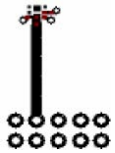
   (b) $R_{\theta JA}$ = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.

   (c) $R_{\theta JA}$ = 69 °C/W when mounted on a 1 in^2 pad of 2 oz copper, 1.5 ” x 1.5 ” x 0.062 ” thick PCB. For dual operation.

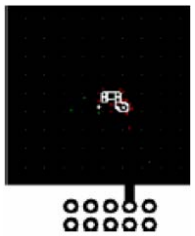
   (d) $R_{\theta JA}$ = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.



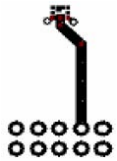
a)86 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



b)173 °C/W when mounted on a minimum pad of 2 oz copper.



c)69 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



d)151 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics Q1 (N-Channel)

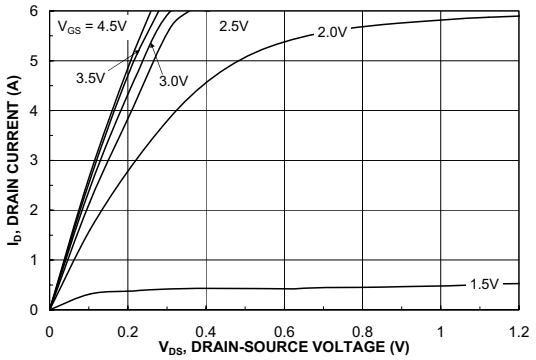


Figure 1. On-Region Characteristics.

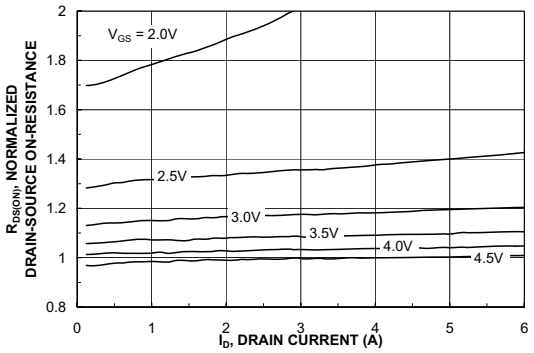


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

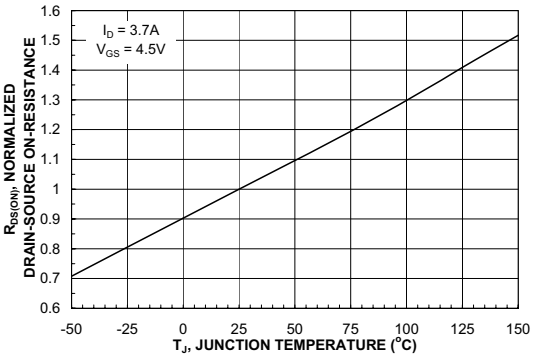


Figure 3. On-Resistance Variation with Temperature.

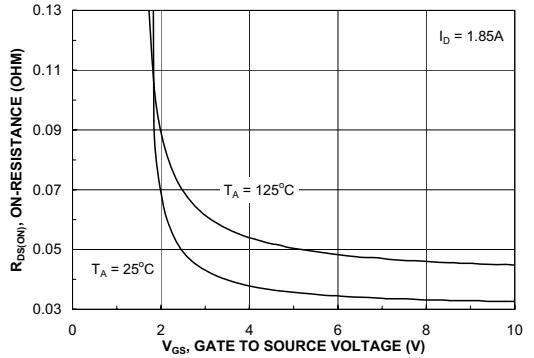


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

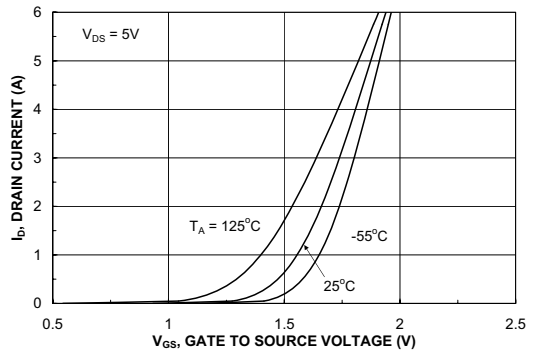


Figure 5. Transfer Characteristics.

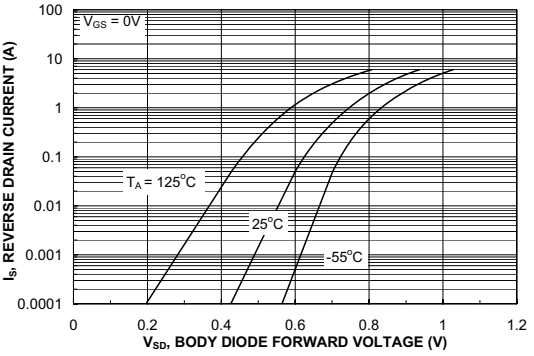


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics Q1 (N-Channel)

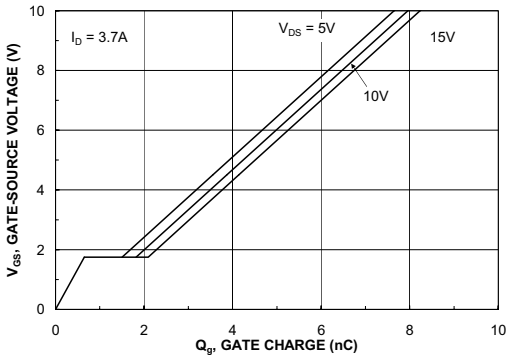


Figure 7. Gate Charge Characteristics.

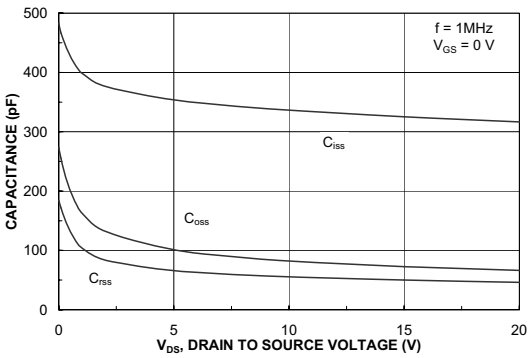


Figure 8. Capacitance Characteristics.

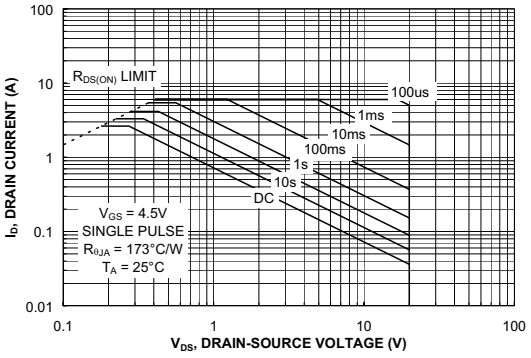


Figure 9. Maximum Safe Operating Area.

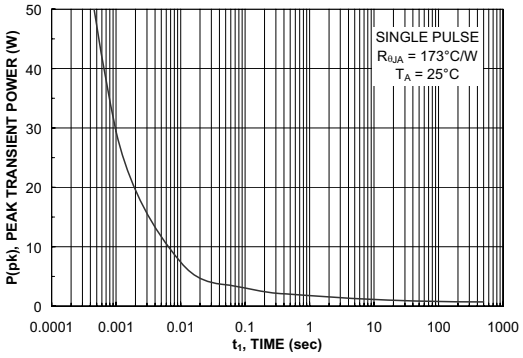


Figure 10. Single Pulse Maximum Power Dissipation.

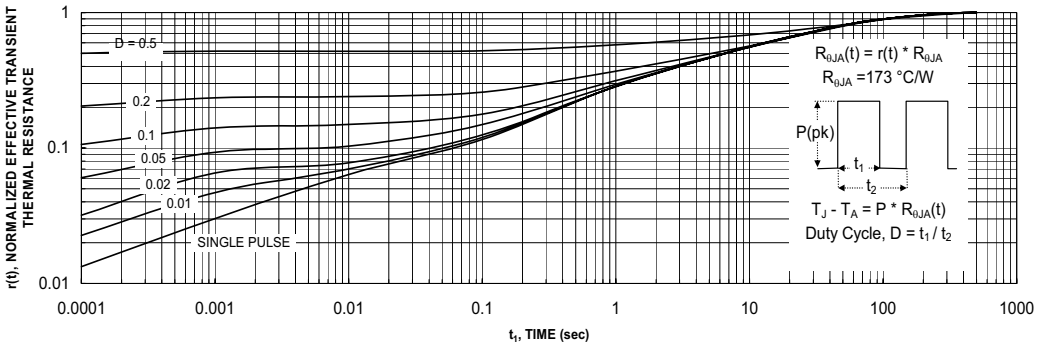


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.
Transient thermal response will change depending on the circuit board design.

Typical Characteristics: Q2 (P-Channel)

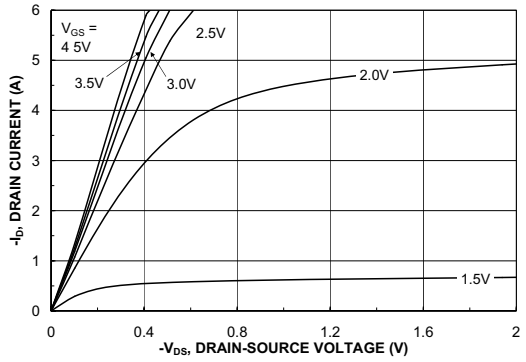


Figure 12. On-Region Characteristics.

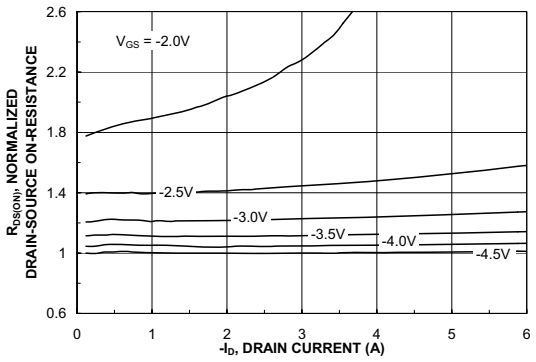


Figure 13. On-Resistance Variation with Drain Current and Gate Voltage.

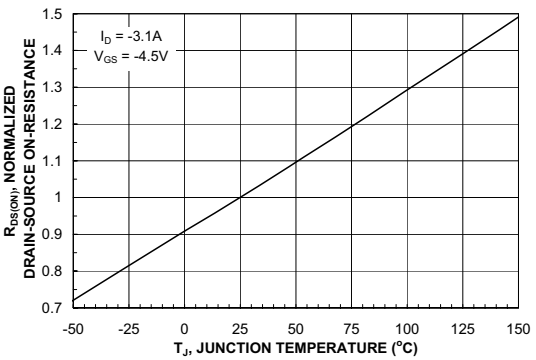


Figure 14. On-Resistance Variation with Temperature.

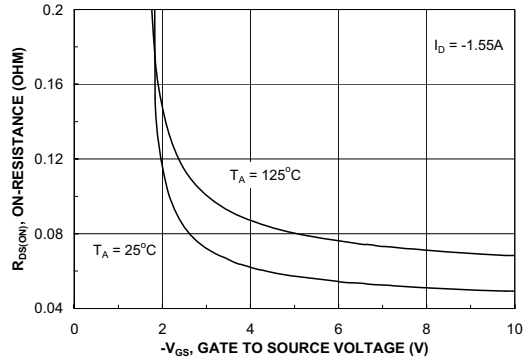


Figure 15. On-Resistance Variation with Gate-to-Source Voltage.

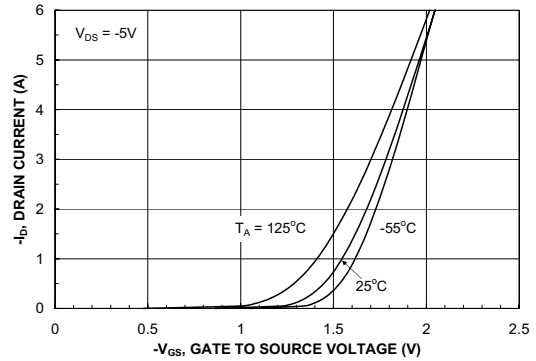


Figure 16. Transfer Characteristics.

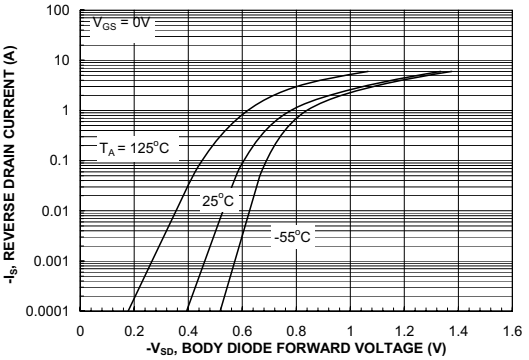


Figure 17. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2 (P-Channel)

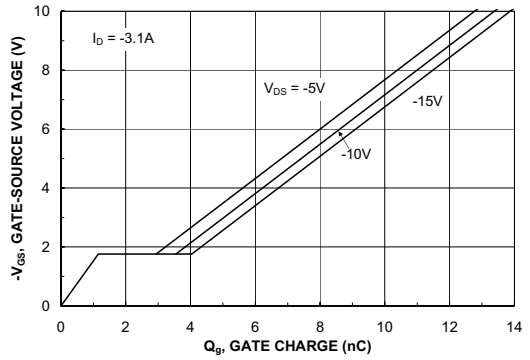


Figure 18. Gate Charge Characteristics.

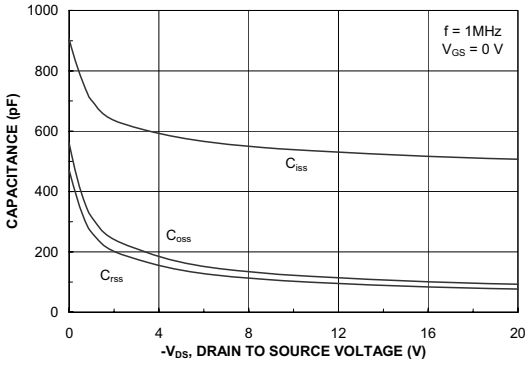


Figure 19. Capacitance Characteristics.

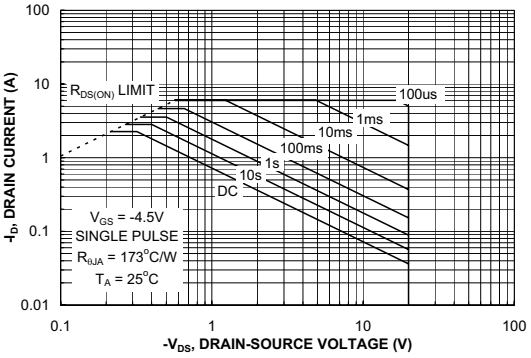


Figure 20. Maximum Safe Operating Area.

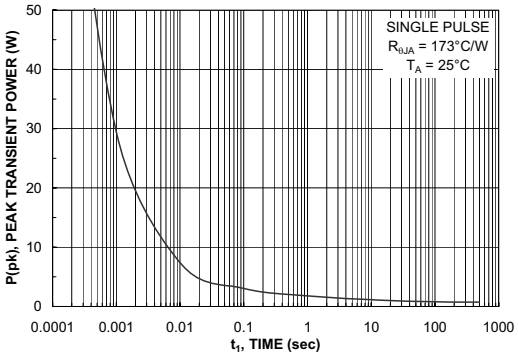


Figure 21. Single Pulse Maximum Power Dissipation.

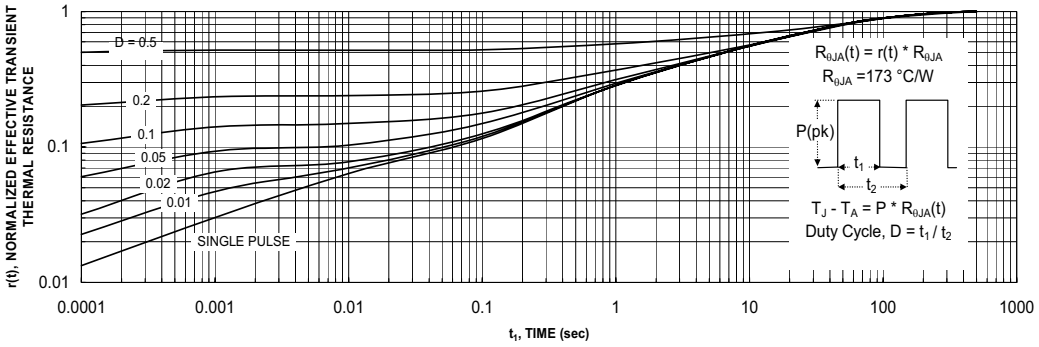
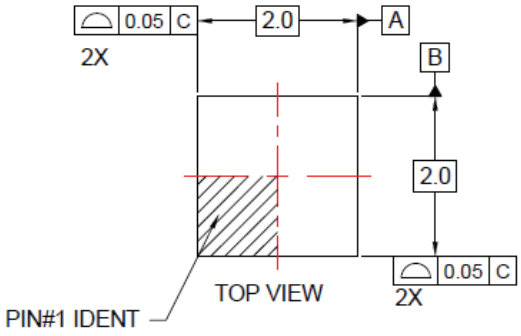
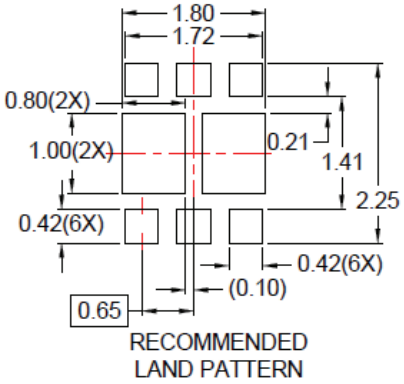


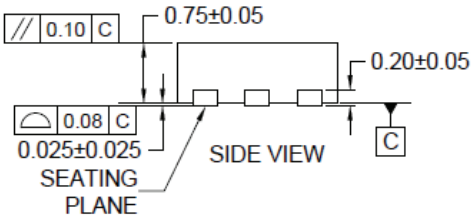
Figure 22. Transient Thermal Response Curve.

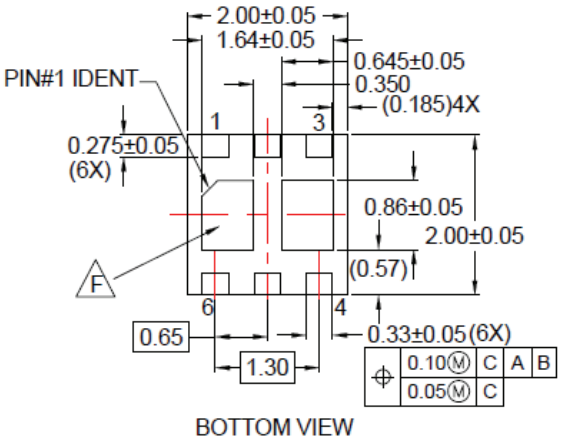
Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout









NOTES:

A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.

B. DIMENSIONS ARE IN MILLIMETERS.

C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.

D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

E. DRAWING FILENAME: MKT-UMLP16Erev4

F. NON-JEDEC DUAL DAP

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http://www.fairchildsemi.com/package/packageDetails.html?id=PN_MLDEB-X06

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FACT®
FAST®
FastvCore™
FETBench™
FPS™
F-PFS™
FRFET®
Global Power Resource℠
GreenBridge™
Green FPS™
Green FPS™ e-Series™
G*max*™
GTO™
IntelliMAX™
ISOPLANAR™
Marking Small Speakers Sound Louder and Better™
MegaBuck™
MICROCOUPLER™
MicroFET™
MicroPak™
MicroPak2™
MillerDrive™
MotionMax™
mWSaver®
OptoHiT™
OPTOLOGIC®
OPTOPLANAR®
PowerTrench®
PowerXS™
Programmable Active Droop™
QFET®
QS™
Quiet Series™
RapidConfigure™
Saving our world, 1mW/W/kW at a time™
SignalWise™
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SPM®
STEALTH™
SuperFET®
SuperSOT™-3
SuperSOT™-6
SuperSOT™-8
SupreMOS®
SyncFET™
Sync-Lock™
SYSTEM GENERAL ®*
TinyBoost®
TinyBuck®
TinyCalc™
TinyLogic®
TINYOPTO™
TinyPower™
TinyPWM™
TinyWire™
TranSiC™
TriFault Detect™
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Definition of Terms

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